Currents, Torques, and Polarization Factors in M agnetic Tunnel Junctions

J.C.Slonczewski¹

IBM Watson Research Center, Box 218, Yorktown Heights, NY 10598 USA

Received by Phys. Rev. B on April 7, 2004. Revised on

M arch 22, 2022

Abstract

Bardeen's transfer-ham iltonian m ethod is applied to m agnetic tunnel junctions having a general degree of atom ic disorder. The results reveal a close relationship between m agneto-conduction and voltage-driven pseudo-torque, and also provide a m eans of predicting the thickness dependence of tunnelpolarization factors. Am ong the results: 1) The torque generally varies with m om ent direction as sin at constant applied voltage. 2) W henever polarization factors are well de ned, the voltage-driven torque on each m om ent is uniquely proportional to the polarization factor of the other m agnet. 3) At

nite applied voltage, this relation in plies signi cant voltage-asymmetry in the torque. For one sign of voltage the torque remains substantial even if the magnetoconductance is greatly diminished. 4) A broadly de ned junction model, called idealmiddle, allows for atom ic disorder within the magnets and F/I interface regions. In this model, the spin-() dependence of a basis-state weighting factor proportional to the sum over general state index p of (s s dydz $_{\rm p}$;)² evaluated within the (e.g. vacuum) barrier generalizes the local state density in previous theories of the tunnel-polarization factor. 5) For small applied voltage, tunnel-polarization factors remain legitimate up to

rst order in the inverse thickness of the ideal middle. An algebraic form ula describes the rst-order corrections to polarization factors in terms of new ly de ned lateral auto-correllation scales.

PACS:85.75.-d

1 Introduction

When ist predicted, voltage-driven pseudo-torque in magnetic tunnel junctions (MTJs) appeared to be a marginal e ect [1]. (Sec. 2 explains our use of the prex pseudo- in the term pseudo-torque.) The lithographic scales and resistances available in early experimental MTJs appeared too large to permit anything more than a very small torque term in the Landau-Lifshitz equation. Resistive heating of the MTJ would have limited its possible consequences to only a small voltage-driven decrease of linew idth of narrow ly-focussed Brillouin scattering. (This prediction was never tested.) As a result, one could not yet predict anything as remarkable as the now well-established magnetic reversal and high-frequency precession observed when the resistive barrier is replaced by a metallic spacer. For recent experimental work and earlier references dealing with switching and current-driven oscillations involving metallic spacers, see Refs. [2] and [3].

But in recent years, experimental activity in tunneling magnetoresistance has expanded vastly. It is fueled in great part by the experimental discovery of substantial tunneling magnetoresistance [4] at room temperature and the resulting intensive exploration of non-volatile magnetic memory reviewed recently [5]. A part of this activity is the search for junction compositions and deposition techniques which lower the resistance to values more suitable for integrated-circuit application. Indeed, there now exist very recent experimental reports of current-driven switching in M T Js [6, 7]. This development may make possible two-term inal memory elements avoiding resort to three-term inal devices using both a metallic spacer for switching and a tunnel barrier for reading [8].

A coording to recent reviews of tunneling magneto-resistance [9, 10, 11, 12], em – pirical ferrom agnet polarization coe cients P_i [i = L,R refer to left and right magnets F_i in Fig. 1(a).] measured with F_iIS junctions having a superconducting counter electrode [13] account well form agneto-resistance in FIF junctions. Let the form ula

$$J(V;) = J_0(V)[1 + (V)\cos]; \text{ with } J_0 > 0 \text{ for } V > 0$$
 (1)

for current density at constant applied voltage V de ne the dimensionless coe cient of magneto-conduction. Here is the angle between the moments. (The sign occurs in Eq. (1) because of the convention in Fig. 1 where particle-num ber current is positive for V > 0.) In this article, the coe cient is more convenient than the experimentally preferred low -voltage tunneling-magnetoresistance ratio

$$TMR = (R_{AP} \quad R_{P}) = R_{P} = 2 = (1)$$
; (2)

¹IBM RSM Emeritus.

john slonczew ski@ verizon net

The original equation due to Julliere [14], expressed in our notation by the form ula

$$= P_{\rm L} P_{\rm R}; \qquad (3)$$

enjoys considerable success in interpreting experiments [9]. We not below that whenever separates this way into two polarization factors characteristic of the respective electrode-and-barrier compositions, pseudo-torque expressions having dimensionless coe cients $_{\rm L}$ and $_{\rm R}$ [See Eqs. (13), (19), and (20) below .]; whose simplicity parallels that of Eqs.(1) and (3), hold also. The presence of the same average current density J_0 (V) in equations both form agneto-current and torque represents a strong connection between these two phenomena.

A fter the commonalities in Secs. 2 and 3, these mutual relations (Secs. 4 and 5) between magneto-conductance and pseudo-torques constitute the rst of two parts of the present article. The second part (Secs. 6 and 7) is stimulated by the fact that theory does not generally support the separability of spin-channel currents into the left-dependent and right-dependent factors needed to justify polarization factors in the rst place. Previous theories attack the question of polarization coe cients within the context of real electron structure by considering the transmission of electrons initially occupying well-de ned crystalline-momentum states [15, 16, 17]. They posit either complete absence of disorder or special types of disorder only within the barrier to legitim ize tunnel-polarization factors. The present approach, detailed below, complements those works by excluding disorder only from a subregion of the barrier.

E lectron scattering, which causes m etallic resistivity, abounds within experim ental M T J electrodes. A new feature of the present work is to forego altogether crystalm on entum quantization within the electrodes. This feature is particularly appropriate to contem poraneous experiments relying for electrodes on evaporated or sputtered m agnetic elements and alloys having high defect concentration [2, 3, 6, 7]. B oth alloying and structural defects m ay cause an electron to scatter m any times within the electrodes before and after it tunnels across the barrier so that initial and nal crystalm om enta are unde ned.

O urelastic-tunneling theory rests on Bardeen's transfer-ham iltonian m ethod (BTM) [18,19], which is applicable to tunneling transitions between therm albaths of electron states w ithout any spatially conserved observables. Bardeen de nes two sets of basis states one for the left electrode and barrier and one for the right electrode and barrier. Ferm i's "golden rule" for transition rates gives the tunneling current. Thus our theory of MT Js has broader application than m any others, previously reviewed [9, 11, 12], which rely on scattering of Bloch electrons. A lthough m ore m odem than

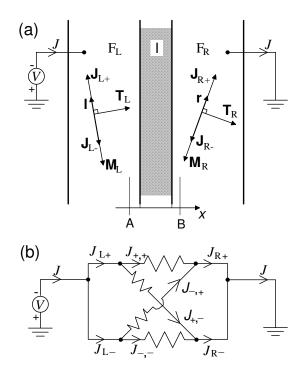


Figure 1: (a) Scheme of magnetic tunnel junction and key to notations. (b) Equivalent circuit for spin-channel currents and further key to notations.

Bardeen's method, they must assume de ned initial and nalm omenta.

O ur model of the junction, called ideal middle, excludes disorder only from a central geom etric slab of uniform thickness w, which may consist of vacuum or periodic crystal lying som ewhere within the barrier. We not that exact factorization of channel-to-channel current, which leads to Eqs.(3) and (19) below, occurs in the limit w ! 1; just as in the case of complete absence of disorder. Further, our parametrization of lateral auto-corellation (See Sec. 7) of the Bardeen basis-function sets predicts well-de ned tunneling-polarization factors for nite barriers to rst order in w⁻¹; which enhances their legitim acy for interpretation of experiments involving any degree of disorder. C om putations and measurem ents of the new corellation-scale parameters could shed quantitative light on the genesis of polarization factors.

By way of organization, Section 1 is this Introduction and Section 2 shows how

spin-channel tunnel currents generally determ ine voltage-driven torque. Section 3 uses the BTM to derive the resulting fully general expressions for the magneto-conduction, the torques, and the relevant dimensionless coecients , $_{\rm L}$; and $_{\rm R}$. Section 4 shows how tunneling-polarization factors and the resulting simple expressions for , $_{\rm L}$; and $_{\rm R}$ arise from a form al separability condition. Section 5 addresses the expressions for voltage-unsymmetric torque arising from voltage dependences of polarization factors. Section 6 demonstrates the separation condition and derives the tunnel-polarization factors which arise in the ideal-middle model at w ! 1 : Section 7 expands the magnetic tunneling properties for nite w and derives a form ula for the rst-order w ¹-dependence of tunnel-polarization factors. Section 8 summarizes and discusses the results.

2 First currents, then pseudo-torques

W henever two ferrom agnets are separated by a nonm agnetic spacer, whether a tunneling barrier or a m etal, exchange-generated pseudo-torques acting on the m agnetic m om ents are attributable to the ow of spin-polarized current. For a fuller discussion of the genesis of pseudo (or e ective)-torque from the principle of spin continuity, see Appendix B of Ref. [20]. Essential is the interpretation of m agnetization dynam ics

(M dM =dt) governed by the additive term s in the macroscopic Landau-Lifshitz

equation. Ordinarily M represents the precession in place of electron-spin momentum localized to a volume element dV due to local causes like magnetic eld, spin-orbit coupling, etc. But the term describing externally driven spin transfer is transparently di erent. It re ects directly the ow of spin momentum directly into dV.

Indeed, the same m ay be said about the phenom enological exchange sti ness described commonly by the eld 2Ar²m; with M M_sm: This truth is masked by the derivability of ordinary exchange torque from variation of the stored energy density A $_{i;j}$ ($m_i=m_j)^2$: Because spin transfer is driven by an externally supplied current or voltage, its elect cannot be derived from a stored energy. Therefore, its calculation requires direct recourse to spin currents as detailed below. Since this distinction between torque and divergence of polarization m akes no di erence in the subsequent application of the Landau-Lifshitz equation, the pre x "pseudo-" will be om itted in the remainder of this article.

Return now to our problem of spin-transfer torque created by external voltage applied to the MTJ.Consider particularly the series electric circuit in Fig. 1 (a) in which an external voltage V causes electric-current density J to ow in series through a left m etallic ferrom agnetic lm F_L , a thin insulator I serving as a tunnel barrier, and nally a grounded right m etallic ferrom agnetic lm F_R . By assumption, F_L is su ciently thin for the direction of spontaneous m agnetization M $_L(x) = M_L(x)l$ within F_L not to depend on the plane-perpendicular coordinate x; sim ilarly M $_R(x) =$

 $M_R(x)rw$ ithin F_R : But the spontaneous magnetizations M_L and M_R may vary with x. (Here the three-dimensional unit vectors land r include the angle = $\cos^1 r$ l:) Thus we lay aside those possibilities of forward spin-wave excitation [21] and volum e-intensive torque [22], arising from dependence of magnetization direction on x; which become signi cant for larger in thickness and current density.

One goal is to calculate the component T_R of interfacial torque vector T_R per unit area, acting on M_R ; which lies orthogonal to r within the instantaneous plane common to l and r as indicated in Fig. 1a: (The orientation of the magnetic space spanned by lorr is completely disconnected from that of position space x; y; z:) A general expression for T_R [20, 23] reads thus:

$$T_R = \sim [J_{L,+} \quad J_L, + (J_R, \quad J_{R,+}) \cos] = 2e \sin$$
 (4)

Here the left spin-channel electric current densities J_L , = J_L , l ow through plane A (See below) in direction x and the right J_R , = J_R , r ow through plane B. The factor ~=2e converts any electric channel current to one of spin m om entum. A similar expression holds for the pseudo-torque T_L on the left m om ent. The torques T_R and T_L m ust generally be included in the dynam ic Landau-Lifshitz equations for the two magnetic lm s.

A though previously applied only to all metallic multilayers, Eq. (4) may also be used when the spacer is an insulator. For its derivation, one posits the nonrelativistic n-electron ham iltonian including, besides kinetic energy, coulomb term s due to external voltage and electron-nuclear and electron-electron interactions. In addition, one accepts the microscopically-based approximation, defensible in the case of Co, that the transverse (to local M) components of conduction-electron spin polarization created at the two internal I/F interfaces decay to zero well within a 1nm [20], which was estimated explicitly for Co/Cu and characteristic distance d₂ other interfacial compositions by scattering computations [24]. Moreover, in one experiment the threshold current for switching of Co by polarized current owing through a metallic spacer is simply proportional to lm thickness down to 1 nm, con ming that the transverse polarization inside the ferrom agnetic lm vanishes at this scale [25]. Therefore the currents in the left and right magnets must be polarized along instantaneous left (1) and right (r) moment axes at depths greater than d_2 from the F/I interfaces. Thus our work excludes thicknesses < 1 nm, which require special treatment sensitive to atom ic layering [26].

In the extensive literature on tunneling magnetoresistance involving Fe, Co, N i and magnetically concentrated alloys of these elements with others of lower atom ic number, there is little indication of spin relaxation at I/F interfaces. Moreover experiments at cryogenic temperatures reveal that the distance $_{jj}$ of spin relaxation due to spin-orbit coupling for the polarization component along the axis M is about 50 nm for Co and about 5.5 nm for N iFe [27]. Thus it follows that, at least in the case of Co where $_{jj} >> d_2$, the channel currents J_L , and J_R , should be evaluated at the planes A and B lying at the distance d_2 from the respective F/I interfaces. For within the space between these planes one may neglect spin-orbit e ects and embrace the well-known spin-continuity relation which equates the sum of equivalent interfacial pseudo-torques with the net in ow of spin current [20, 23], having polarization directions l on the L side and r on the R side. In the notation of Fig. 1 (a), the statistical average of this equality becomes

$$T_{L} + T_{R} = \frac{\sim}{2e} [(J_{L}, J_{L,+})] + (J_{R,+} J_{R},)r];$$
 (5)

By our assumed neglect of changes in M_L; we write 1 $T_{\rm L} = 0$: Therefore the scalar product of Eq. (5) with lelim inates T_L and gives Eq. (4) for the magnitude T_R: A similar equation holds for T_L.

The above argument neglects a decaying and spatially oscillating transverse current, calculated in certain FNF cases to lie between 0 and ' 10% of the incident spin current (See Fig. 7 of Ref. [24]). It is likely due to specular interference created at the perfect interface assumed in the calculation. Studies of FMF exchange coupling in vogue 10 years ago suggest that extrem als in the Ferm i surface determ ine the wavelength and cause the amplitude to decay with distance. The amplitude will be decreased by irregularities at real in perfect interfaces.

Even in the absence of applied electric voltage (V = 0) an additional perpendicular component of exchange pseudo-torque $T_{R?} = K l r = T_{L?}$ predicted for M T Js [1] is generally related to phenom enological coupling energy $K l r = K \cos s$. It must also be included in the Landau-Lifshitz equation for the dynam ics of magnet $F_{R.}$ However, in that toy rectangular-barrier M T J m odel [1], the (uncalculated) dependence of $T_{R?}$ and $T_{L?}$ on applied voltage occurred only in higher order (V^2) than the torque given by Eq. (4) (V). Moreover, its dynam ic e ect is relatively weaker in structures with coincident easy anisotropy axes and low magnetic dam ping, such as the pillars using m etallic spacers experimentally favored for e cient currentdriven switching [2]. Indeed, steady oscillation excited by a steady electric current, such as that observed [2, 3], is possible with $T_{R?} = 0$; but not in the absence of inplane T_R : In addition, the BTM used here does not readily provide this out-of-plane torque. For these reasons, we do not attempt to predict the perpendicular torque component in this work.

3 M agneto-conduction and torques

Equation (4) e ectively reduces the interacting-electron problem of voltage-driven torque to the custom arily independent-electron problem of spin-channel currents. One recently reviewed BTM -based theory of collinear MTJ magnetoresistance [11] extends naturally to tunneling between spin channels for general : For adaptation of the BTM [18, 19] to the MTJ of Fig. 1a, a stationary basis state p; i within the electron reservoir F_{L} is assigned orbital index p and m a prity/m inority spin quantized along axis 1. It satis es $(H + eV)_{p;}$ i = 0; and decays exponentially within the barrier, considered sem i-in nite in width when de ning the basis states. Here, $H = p^2 = 2m + p^2$ jiU (x;y;z)h ; where the potential U depends on spin within the ferrom agnets according to intinerant-electron m agnetism theory [28], but not within the barrier. Within F_R ; a similar state satisfies (H a: 0 $\dot{\eta}; \dot{\eta}: 0$ $\dot{\eta}: 0$ with quantization axis r. Because the barrier is assumed to dom inate all other resistances of this circuit, the spin channels are shown in Fig. 1 (b) as shorted in each magnet and/or external-contact region by spin lattice relaxation due to spin-orbit coupling. One may disregard spin accumulation and the related distinction between electric and electrochem ical potentials which are important when a non-m agnetic m etallic spacer substitutes for the barrier [29]. U includes all elastic terms arising from atom ic disorder due to alloying, defects, interfacial atom ic interdi usion, etc. The state indices p;q sim ply enum erate the exact eigenstates p; i; jq; ⁰i of H in the Bardeen basis. Each such state incorporates e ects of all multiple elastic scatterings without lim it.

Employing the spinor transform ation connecting quantization axes 1 and r, the transferm atrix element takes the form

hp;
$$H$$
 "jq; $^{0}i = \frac{p_{i}+p_{i}+\cos 2}{p_{i}+p_{i}+\sin 2} \frac{p_{i}+p_{i}}{p_{i}+p_{i}+p_{i}} \frac{\sin 2}{\cos 2}$: (6)

Direct extension of BTM [30] to our spin-dependent case gives the expression

$$P_{p; q; 0}(\mathbf{x}) = \frac{\sim^{2} R}{2m} dy dz \left(P_{p; q; 0} q_{q; 0} q_{q; 0} \right) \left(P_{q; q; 0} q_{q; 0} \right)$$
(7)

where the integral is over unit area for coordinate x lying appropriately (see below) inside the barrier. The energies $_{p}$; and $_{q}$, \circ may dier only in nitesimally from

the Ferm i value " = "_F: The ham iltonian H; the left ($_{p}$;) and right ($'_{q}$; $_{o}$) orbital wave functions, and these m atrix elements (7) are real.

Only the neglect of cross-barrier overlaps hp; jq; ⁰i allow suse of the Ferm igoden rule of perturbation theory which is strictly valid for an orthonorm albasis. Substitution of the perturbation (6) into this rule is followed by sum mation over the initial states in an in nitessim all energy band of width eV: Thus the partial electric current density owing between channel in F_L and channel ⁰ in F_R becomes

$$J_{; \circ} = \frac{2 e^2 V P_{\circ}}{\sim} p_{pq} h p; H_{F} ''_{F} j ; {}^{0} i^2$$
(8)

at T = 0 K. The ⁰ in $P_{p,q}^{0}$ in poses the conditions $"_{F} < ("_{p}; ;"_{q}; \circ) < "_{F} + eV$: Notations in the equivalent circuit shown in Fig. 1 (b) make plain the relations

$$J_{\rm L} = J_{;+} + J_{;}; \quad J_{\rm R} \circ = J_{+;} \circ + J_{;} \circ; \quad (; {}^{0} =)$$
(9)

needed in Eq. (4). The right hand sides of these equations are evaluated from Eqs. (6-8).

Next we write the total electric current density $J = J_{L,+} + J_{L,-}$: W ith the notation

$$; \circ = \frac{2 \text{ eV } P}{\sim} \int_{p_{iq}}^{0} \int_{p_{ij}}^{2} g_{ij} \circ (10)$$

for interchannel particle-num ber tunneling conduction with the angular factor om itted, the above equations combine to give Eq. (1) with

$$J_0 = e(_{+;+} + _; + _{+;} + _{;+}) = 2$$
(11)

and the electric magneto-conduction coe cient

$$= e(_{+,+} + _{;} + _{;} + _{;+}) = 2J_0:$$
(12)

Eq.(4) becomes

$$\Gamma_{\rm R} = (P_{\rm R} J_0 = 2e) \sin (13)$$

or, in coordinate-free form

$$T_{R} = (I_{R} J_{0} = 2e)r (1 r);$$
 (14)

with the torque coe cient

$$_{R} = e(_{+;+} + _{+;} ; ; ; +)=2J_{0}:$$
 (15)

The fact that the linear combination of the parameters $; \circ$ appearing in Eq. (12) diers from that in Eq. (15) and a similar one for T_L precludes any fully general connection between torques and electrical current.

4 Left-right separability and polarization factors

Particularly interesting relations arise if the summation in Eq. (10) for the interchannel particle current happens to separate into left- and right-dependent factors in the form

$$; \circ = f_{L; R}, \circ:$$
 (16)

Here the coe cient f, which we make no attempt to evaluate, is independent of ; 0 . (Sections 6 and 7 address conditions for this separability.) For then Eq. (11) gives

$$J_{0} = \frac{ef}{2} \left({}_{L;+} + {}_{L;} \right) \left({}_{R;+} + {}_{R;} \right)$$
(17)

and Eq. (12) gives Eq. (3) with the tunneling polarization parameters

$$P_{i} = \frac{i;+ i;}{i;+ + i;} \quad (i = L_{R})$$
(18)

which are directly measurable using FIS junctions [9]. In these terms, Eqs. (1) and (3) give the magneto-conduction and Eq. (14) the torque with

$$_{R} = P_{L} :$$
 (19)

Sim ilarly, the torque on the left m agnet is

$$T_{L} = (J_{L} J_{0} = 2e) \sin ; L = P_{R}$$
 (20)

or, in coordinate-free form

$$T_{L} = \frac{2}{2e} J_{0} l$$
 (r l): (21)

The Eqs.(3), (19), and (21) show the very close relation between current-driven torques and magneto-conduction at the same voltage, summarized by $= L_R$; if the separability condition (16) is satis ed:

The ground-breaking paper of Julliere [14] gave equations equivalent to (3) and (18) taking $_{\rm L}$ and $_{\rm R} \circ$ to be spin-dependent basis-state densities at " = "_F. It appeared to attribute the dimensionless magneto-current coeccient = P $_{\rm L}P_{\rm R}$ to bulk properties of the two magnetic compositions involved. But the analytically solved free-electron rectangular-potentialm odel [1] shows that an interface-dependent factor must be included in $_{i_{f}}$ as well. The transfer-ham iltonian treatment of this toy m odel follows immediately from the spinless treatment [30] giving

$$i_{i} = k_{i} = \begin{pmatrix} 2 \\ 0 \end{pmatrix} + k_{i}^{2} \end{pmatrix}$$
 (22)

$$k_{i;}^2 = 2m E_{i;} = \{ \}^2 \text{ and } \{ 0 \}^2 = 2m B = \}^2$$
: (23)

Here, E_{i} ; is the kinetic energy at the Ferm i level and B is the barrier potential measured from the Ferm i level. Equation (18) now gives

$$P_{i} = \frac{k_{i;+} + k_{i;}}{k_{i;+} + k_{i;}} - \frac{{}^{2}_{0} + k_{i;+} + k_{i;}}{{}^{2}_{0} + k_{i;+} + k_{i;}}$$
(24)

in agreem ent with R ef. [1]. In this form ula, the rst factor depends purely on basisstate densities in the m agnet, while the second m ixes m agnet and barrier properties. The results of the toy m odel [1] satisfy the generalm agneto-conduction relations (1), (3) and torque relations (14), (19), (21) with this substitution.

We note in passing that experimental variation of barrier height B shows considerable support for the zero of at the barrier potential satisfying 2_0 k_{i+}k_i = 0 expected from Eq. (24) [31] (for sm all V): Therefore, in spite of its fundamental naivete, this toy model enjoys some degree of credibility. It illustrates the general fact that, even when separability holds, each polarization factor is a property of the electron structure of the magnet and barrier combination as demonstrated by m any experiments and calculations. Section 7 will discuss how tunnel polarization may vary with barrier thickness.

5 Finite bias and torque asym m etry

In experiments, TMR typically decreases significantly with increasing nite V [9]. Voltage-dependence of interfacial transmission, special state density distributions, extrinsic in purity elects, and inelastic tunneling contribute to this decrease [9, 12]. This is important because large voltages will be required to read and write in a 2-term inalmemory element.

The toy polarizations of Eq. (24) will serve to illustrate qualitatively the very unsymmetric e ect of nite V on voltage-driven pseudo-torque. One calculation of TMR uses the WKB approximation for the free-electron wave function within the constant-slope barrier potential sketched in Fig. 2 [32]. The interfacial transmissions are approximated by those of the at-potential polarizations (24). The authors cite some experimental support for their results.

It is the decrease of P_i in the particular electrode which collects the tunneled electrons that primarily accounts for the decrease of in the calculated result [32]. In Fig. 2, for V > 0; the collecting electrode lies on the right. Note that the electrons whose energy lies in a narrow band (shaded in Fig. 2) just below the Ferm i level

where

of the em itting electrode on the left of the barrier dom inate the tunneling current because of the strong energy dependence of the W KB factor exp[2 (x)dx] in the transm ission coe cient. Since these hot electrons lie an am ount well above the Ferm i level on the right, this energy shift eV m ust be taken into account when estim ating P_R :

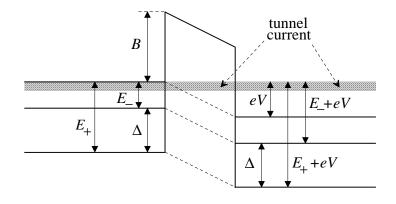


Figure 2: Schematic junction potential for nite V. The shaded bar indicates the energy range of most of the tunneling electrons.

We simplify this model one step further and neglect the width of the shaded current band in Fig. 2. It is then clear that Eqs. (23) and (24) with i = L are still correct for P_L ; neglecting correction for the nite slope of the barrier potential: However, the equations

$$k_R^2 = 2m (E_R + eV) = \}^2$$
 and ${}_0^2 = 2m (B eV) = \}^2;$ (25)

obtained by adding eV to each electron energy on the right, must replace Eqs.(23) for i = R.

Figure 3 plots the curves $_{\rm L} = P_{\rm R}$ and $_{\rm R} = P_{\rm L}$ evaluated from the preceding three equations as well as TM R from Eqs. (2) and (3) versus V for the special example of a sym metric junction with the parameters $k_{\rm L} = k_{\rm R}$ k; $k_{\rm L+} = k_{\rm R+}$ 10k; and $_0 = 6.4$ k; whereby each electrode has the V = 0 polarization $P_{\rm L} = P_{\rm R} = 0.5$: In this illustration, TM R (V) is sym metric because it involves both $P_{\rm L}$ and $P_{\rm R}$ but $P_{\rm L,R}$ (V)

and the torque coe cients $_{L,R}$ (V) are not. A lthough the theory preceding this section assumed small V; the present discussion makes reasonable the application of the results to nite V with the understanding that the polarization of the collecting electrode generally depends more strongly on V: Of course, this toy calculation cannot make quantitative predictions of the V-dependence which must rest on details of electron structure [9, 12].

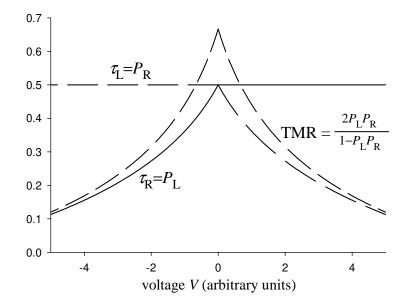


Figure 3: Schem atic e ect of nite voltage on TMR, polarization, and torque $\infty e - cients$ illustrated by the toy free electron m odel of a physically symmetric magnetic tunnel junction. Note that TMR is symmetric but the other ∞e cients are not. The parameters are $_0 = 6.4k$, $k_+ = 10k$:

Note that while critical current density for magnetic excitation is appropriate to junctions with m etallic spacers, the high resistance of a M T J makes critical voltage more appropriate. (Indeed, strictly speaking, the critical current of a constantcurrent generator will generally di er from the current density owing at threshold in the presence of constant external voltage.) A nother signi cant di erence between m etallic and insulating spacers lies in the angular symmetry of the torque. The xed sin -dependence at constant V in the tunneling case has no counterpart in the m etallic case where more general torque expressions typically contribute to asymm etry of excitation threshold [20]. Now we see that the non-ohm ic resistance of a tunneling barrier gives rise to the torque asymmetry of $_{\rm R}$ (V) exhibited in Fig. 3, which naturally rejects in yet another origin for asymmetry of voltage threshold.

6 Ideal-middle model for separability

A recent publication compares existing theoretical arguments supporting the existence of tunnel-polarization factors [17]. Each of them assumes incident states with de nite crystalline momentum. One common type of argument assumes complete absence of disorder so that the tunneling through a thick barrier is dominated by a single value of lateral momentum. A di erent model of T symbal and Pettifor [15] recovers factorization and therefore the Julliere formula in a tight-binding singleband model disordered only within the barrier. Sim ilarly, the model of M athon and U m erski attributes the factorization to phase decoherence due to disorder within the barrier [9, 16]. These treatments are augmented with arguments based on the Feynman path integral in a disordered barrier [17]. Our treatment below complements these arguments with the contrary tack of foregoing lateralm omentum quantization completely within the middle of the barrier.

Figure 4 indicates the structural scheme. The left $(p_{p};)$ and right $('q_{p};)$ orbital basis functions for the transferm atrix, introduced in Sec. 3, are governed in detail by the general potential U or 0 depending on crystal structure, alloy composition, defects, F/I interface roughness and atom ic interdi usion, etc. The quantum numbers p and q do not refer to any diagonal operator. Exceptionally, the idealm iddle B of the barrier consists of an ideal crystalline slab or vacuum region de ned by a Х b where the planes x = a; b are dubbed portals of the ideal middle. In order to de ne the left and right basis-state sets of the Bardeen theory, the barrier potential extends into alternative semi-in nite spaces $(a \times x)$ and $(x \times b)$, where it is greater than "F; independent of or periodically dependent on y; z and independent of and 0 The respective conditions $_{p}$; ! 0 for x ! 1 and $'_{q}$, \circ ! 0 for x ! 1 com plete the de nitions of $_{p}$; and $'_{q}$, \circ .

The elective-mass theorem [33] is valid when " is near the bottom $k = k_0$ of the conduction band within region B. Then the evanescent portion of a left-magnet basis function within this region is approximated by

$$p_{j} = p_{j} (x_{j}y_{j}z)u_{cb,k_{0}}(x_{j}y_{j}z)$$
 (26)

where p_{p} ; satisfies (H $_{bar}$ " $_{p}$;) p_{p} ; = 0 and p_{p} ; ! 0 for x ! 1; and $u_{cb,k_{0}}$ is the B loch function for the bottom of the conduction band. The electric barrier

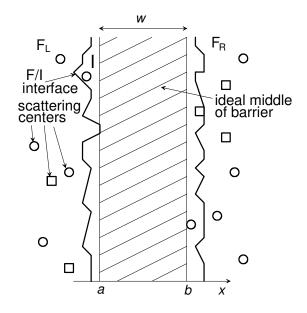


Figure 4: Depiction of the ideal-m iddle model of a magnetic tunneling junction. D isorder without limit is permitted in both electrodes and barrier except within a central slab B of the barrier lying between the portal planes $x = a_i b$:

ham iltonian is $H_{bar} = -2^2 r^2 = 2m_{cb} + U(x)$ where m_{cb} is the elective mass and $U(x) > "_F$ is the spin-independent atom ically smoothed elective barrier potential. Similarly for F_R ; $'_{q; 0} = -q_{; 0} u_{cb,k_0}$ with $q_{; 0} ! 0$ for x ! 1 : In case of vacuum, (;) are indistinguishable from (;'): (Note how ever that this treatment fails if both V is nite and the FI interfaces are disordered, for then U depends on y and z as well as x.)

A ssum ing periodic boundary conditions in the s=(y;z) sub-space, the evanescent portions of left and right basis states within B are conveniently fourier-expanded in space s with the W KB approximation giving

$$\sum_{p; k}^{X} \sum_{k=p; k}^{X} k \left[(k;a) = (k;x) \right]^{1=2} \exp \left[(k;x^{0}) dx^{0} + ik \right]$$

and

where the sum s $_{\rm k}$ are carried over a 2-dimensional reduced Brillouin zone. These form ulas employ the function

 $(k;x) = {}^{2}_{0}(x) + k^{2} {}^{1=2}; \text{ with } {}^{2}_{0} = 2m_{cb} [U(x) "_{F}] = {}^{2};$ (29)

where i is the imaginary component of the wave-vector in region B. Note that Eqs. (27) and (28) reduce to expansions of $_{p}$; and $'_{q}$, \circ with coe cients $_{p}$; (k) and $_{q}$, \circ (k) on the portal planes x = a and x = b respectively.

The transfer-ham iltonian matrix element of Eq. (7) is evaluated at any x lying within the interval a x b. Consequently ; , and m _{cb} may replace , '; and m respectively in this formula. One convenient choice to evaluate Eq. (7) is $x = x_{max}$; satisfying U(x) U(x_{max}) for all x; because the resulting condition $g_0=g(x(x_{max}))=0$ simplies the mathematics. (Inclusion in U of the image potential due to electron-electron correlation will often insure the presence of a maximum, even if jV j is large.) Substitution of Eqs. (27) and (28) followed by integration over y and z, with the assistance of the identity $ds^2 \exp[i(k k^0) s] = k_{ik} c_{i}$; reduces Eq. (7) to

$$P_{p; q; 0} = {}_{k}F(w;k) P_{p; k}(k) q; 0(k)$$
(30)

where

$$F(w;k) = \frac{4^{2} \sim^{2}}{m_{cb}} \stackrel{1=2}{=} (k;a) \stackrel{1=2}{=} (k;b) \exp[\frac{z}{b} dx (k;x)]:$$
(31)

Here we use the barrier-m iddle thickness w = b a; and note $_{p}$, $(k) = _{p}$; (k)and $_{q; 0}(k) = _{q; 0}(k)$ because $_{p}$; and $_{q; 0}$ are real. [N hen w varies in our discussion below, $_{p}$; (k) and $_{q; 0}(k)$ remain unchanged because they pertain to the sem i-in nite barrier independent of w: W e m erely expand or contract the ideal m iddle of the barrier in Eq. (31).] A fter rearranging the order of sum s, Eq. (10) with substitution of (30) and (31) becomes

$$; \circ = \frac{2 \text{ eV}}{2} \sum_{k=1}^{N} \sum_{k=1}^{N} F(w;k) \sum_{k=1}^{N} F(w;k^{0}) L(k;k^{0}) M \circ (k;k^{0})$$
(32)

where each of the two functions

$$L = {}^{\circ}_{p p;}(k) {}_{p;}(k^{\circ}); M {}_{\circ} = {}^{\circ}_{q q;} {}_{\circ}(k) {}_{q; \circ}(k^{\circ})$$
(33)

depends only on parameters of the left and right magnet-and-barrier combinations respectively. The 0 on 0 signi as the conditions given previously for Eq. (8).

In the presence of atom ic disorder, the sum s in Eqs. (33) are carried over m any states of random ized character. Therefore they have the nature of statistical auto-correlations in y;z-space which should depend sm oothly on k and k^0 and are Taylor-expandable about $k = k^0 = 0$. (See Sec. 5 for the very di erent toy free-electron case

of vanishing disorder [1], in which one may form ally replace $p \mid k^{(0)}; q \mid k^{(0)}$ so that L and M $_{\circ}$ become proportional to $_{k,k}$.) In addition, with increasing thickness w = b a of region B, the exponential in Eq.(31) becomes ever more sharply peaked at k = 0: Sum m ation over k and k^0 of the term s in these Taylor series' for nite w gives the corresponding term s

$$; \circ (w) = {}^{(0)}_{i} \circ (w) + {}^{(1)}_{i} \circ (w) + (34)$$

The initial constants in both Taylor expansions yield

$$_{i}^{(0)}(w) = f(w) _{L, R,}^{(0)}$$
 (35)

with $L_{L_{i}}^{(0)}$ L (0;0) and $R_{i}^{(0)}$ M \circ (0;0): Here factors independent of and 0 are absorbed into f: Therefore, to leading order in this expansion, the integrations in Eq. (32) tend to the left-right separation of the form (16).

Written in full, the parameters needed in the general polarization formula (18) are, to lowest order in the Taylor expansions of Eqs. (33), the basis-state weights

RR dydz is carried over unit junction area at the portal positions a and b: where [See the next section for developm ent of $\binom{(1)}{i}$ (w):] Note that the latter two equations di er generally from the local state (or charge) density often cited in connection with $dydz = \frac{2}{p}$;) They reduce to the LSD in the complete absence tunneling. (LSD _ of disorder when each of the two sums reduces to a single term $\frac{2}{k=0}$; and $\frac{2}{k=0}$; independent of y and z.

Correction of polarization at nite thickness 7

The non-orthogonality between left and right basis functions constitutes a basic weakness of the BTM. Even though the validity of golden-rule transition rates in BTM is not generally assured, it has an enormous acceptance in the literature. The toy free electron M T J theory, though founded directly on a solution of the wave equation in the entire ideal non-disordered FIF system having a at barrier potential, was evaluated only to leading order in the exponential parameter e^{w} [1]. The BTM

calculation for the same model agrees exactly with its results, as one knew it should from previous non-spin dependent tunneling theory [19].

Let us assume that BTM is correct to the same exponential degree for our idealmiddle model as for the toy model. The previous section showed that the BTM supports tunnel-polarization phenomenology in lowest order. Continuing with BTM, we derive here a correction to the form ulas (18), (36), and (37) for polarization which we not below varies algebraically, not exponentially, with w¹. Therefore these corrections should be reliable in spite of this general weakness of the BTM.

Further progress requires param etrization of the autocorellation functions de ned by Eq. (33). Note is the consequence of assuming that the possibly disordered atom is conguration in F_L produces no electrostatic potential in F_R and vice versa. From Eqs. (27), (28), and (33), in-plane translation of the (disordered) m icroscopic potential of only the left electrode according to s ! s + (B;C); where (B;C) is a periodic-lattice translation of the barrier middle, has the elects, from Eq. (33), $L ! L \exp[i(k^0 k) (B;C)]$ and $M \circ ! M \circ: A$ veraging over all possible such phase changes makes L and M \circ diagonal and eliminates all term swith k \notin k⁰ from the double sum in Eq. (32). This equation now becomes

$$; \circ = \frac{2 \text{ eV}}{3} \sum_{k}^{X} F^{2}(k) L(k) M \circ (k)$$
(38)

using the now diagonal form s of L and M $_{\circ}$:

Parenthetically, note that in the special case of vanishing disorder, the state indices p and q become m;k and n;k respectively, with m;n the respective band indices and k the lateral crystalline m om entum. Let the basis states be norm alized to unity. Then the diagonal elements of form ulas (33) reduce to

$$L = _{m} j_{m}; (k) j^{2} = v_{x,m}; (k), M \circ = _{n}; \circ j_{n}; \circ (k) j^{2} = v_{x,n}; (k)$$
(39)

with factors independent of and ⁰ om itted. Here $v_{x,m}$; = $@"_m$; (k)= $@k_x$ and $v_{x,n}$; $\circ = @"_n$; \circ (k)= $@k_x$ are velocity components norm alto the junction plane. Their presence in these form ulas follows from the restriction on ⁰ in the basic form ula (8).

To evaluate Eq. (38) for nite disorder, specialize to small V and constant U inside B: A fler evaluation of the integral in Eq. (31), it reduces to the form

$$x^{*}_{, \circ} = f_{1}^{*}_{k} f_{k}^{*} = f_{1}^{*} = f_{1}^{*}$$

where f_1 does not depend on or ⁰: For large w; this sum weights small k heavily, as mentioned above. Therefore parametrize L and M $_{0}$ for small k with the lateral

spatial correlation scales $(, \circ)$ de ned by the form ulas

L (k) = L (0) [L
$${}^{2}k^{2} + O(k^{4})];$$
 (40)
M ${}_{0}(k) = M {}_{0}(0) [L {}^{2}{}_{0}k^{2} + O(k^{4})]$

and approximate Eq. (29) with $_0 + (k^2=2_0)$ in the exponent of Eq. (31). A fler approximating $_k$ (over one BZ) with an in nite integral, one nds by elementary integration a result equivalent, to rst order in w⁻¹; to

$$f_2$$
 (w) L (0) 1 $\frac{0}{w + 0}^2$ M (0) 1 $\frac{0}{w + 0}^2$ (42)

where once again factors independent of both and ⁰ are absorbed into f_2 : Thus to this approximation, ; • once again has the factored form (16). (It appears that in order w ²; ; • does not separate this way into left- and right-dependent factors.) The corrected left polarization factor, according to Eq.(18) reduces upon expansion to

$$P_{L} = P_{L}^{(0)} + \frac{1}{2} \quad 1 \quad P_{L}^{(0) \ 2} \quad \frac{0}{w} \left(\frac{2}{w} + \frac{2}{w} \right) + \dots \quad \text{with}$$

$$P_{L}^{(0)} = \frac{L_{+}(0) \quad L_{-}(0)}{L_{+}(0) + L_{-}(0)};$$
(43)

and similarly for P_R : Thus, from given Bardeen basis functions one can obtain polarization factors, correctly to order w⁻¹; in a disordered electrode-barrier combination.

8 D iscussion

A lthough it is valid only in the lim it of weak transm ission, predictions from Bardeen's tunneling theory [18] are interesting because it does not require electron m om entum within the electrodes to be conserved. Our application to elastic tunneling through ordered or disordered m agnetic tunneling junctions yields these new conclusions:

In Section 3 we found that the torque at constant external voltage is generally proportional to sin [Eq.(13)]. This result is a direct consequence of the single-transition nature of tunneling and the simple form of the spinor transform ation (6). It contrasts with the more general angular dependence conditioned on electron structure and spin-channel resistance parameters in the case of a m etallic spacer [20]. In general, polarization factors do not exist in the absence of special assum p-tions, in agreem ent with previous theory [9, 12].

In Section 4 we found that if the polarization factors are well de ned, then at constant applied voltage the electric current and in-plane torque obey the relations (1), (13), and (20). These sim ilar relations are inter-connected by the presence of the common factor J_0 (V) which we do not attempt to calculate. The dimensionless coe cients in these relations are expressed in terms of the polarizations by $_R = P_L$; $_L = P_R$, $= P_L P_R$; im plying $= _L R$: In particular, these general relations are satis ed by the special results of a direct solution of the Schroedinger equation for the toy model of parabolic bands and ideal rectangular potential barrier [1].

Experimentally, TMR is known to usually diminish with increasing external voltage V [9, 10]. In Section 5 we considered that it is the polarizing factor of the collector electrode which decreases more strongly with V, resulting in the unsymmetric schematic pattern of voltage dependence of torque indicated in Fig. 3. This lack of symmetry due to the relations $_{\rm R} = P_{\rm L}$ and $_{\rm L} = P_{\rm R}$ implies that the threshold voltage for initiation of dynamic excitation will be increasingly asymmetric at the higher values (> 100 mV) likely needed for writing in memory. Cases may well arise in which voltage-driven switching is observed at a voltage su ciently high for TMR to become negligible [7]. Our Fig. 3 indicates how this may happen for switching in but one direction, from AP to P. However, our theory would not explain any symmetric persistence of switching at voltages great enough to destroy TMR, if this is observed.

O ur approach to the validation of polarization factors complements previous studies which accounted for atom ic disorder in the barrier assuming electrode states with well-de ned crystalline momentum [15, 16, 17]. We assume that the barrier is thick and includes an ideal crystalline or vacuum middle region of thickness w as in Fig. 4. Then a new ly derived polarization factor, given by Eq. (43), is valid to rst order in w⁻¹ even in the presence of disorder in the electrodes and interfaces su cient to destroy the conservation of lateral crystalline momentum throughout the electrode and interface regions. The key basis-state weight factors (36) and (37) are more general than the conventional local state density.

Our conclusion that the validity of polarization factors increases with increasing w tends to underm ine our predictions of voltage asymmetry of torque shown

schem atically in Fig. 3. For, experimental spin-transfere ects such as switching will require very thin barriers, making the separability condition assumed in Fig. 3 less valid. Previous proposals [12, 17] that validity of polarization factors is attributable to unique defect states or am orphicity in the barrier are more promising in this respect.

Belashenko and co-authors [17] nd that certain rst-principle TMR computations for realistic barrier thickness may be poorly approximated by proportionality to e ``. This casts additional doubt on the applicability of the ideal middle to the very thin junctions needed for spin-momentum transfer experiments. However, our conclusions from this model may bear signi cantly on magneto-resistance experiments carried out with greater thickness, as suggested below.

Our param etrized expression (43) for dependence of tunnel polarization on idealm iddle thickness w is without precedent. A strong dependence is expected from certain compositions, like Co, Ni, and certain alloys, such as FeCo, lying on the negative-slope region of the Slater-Pauling curve [34]; for, their strong contrast between heavily 4sp-weighted density of ma prity-spin and heavily 3d-weighted density of minority-spin bands may be relected in strongly contrasting m agnitudes of left lateral autocorellation scales + and : Theoretical estimation of the left polarization factor will require prior rst-principle computation of the Bardeen basis functions $p_{\rm p}$; for the disordered electrodebarrier system. From these, one must invert the series (27) to evaluate the diagonal elements of the Fourier coe cients p; : Then Taylor expansion of the diagonal element in the rst Eq. (33) for substitution into the rst Eq. (40) provides the coe cients L (0) and : These parameters must then be substituted into Eqs. (43) to obtain the left polarization factor.

In fact, experimental junctions having composition Fe/A $\frac{1}{20}$ /FeC o show dependence of TMR on barrier thickness [10] at T = 2 K where our assumption of elastic tunneling should be valid. A monotonic dependence on thickness, expected from Eq. (42), is observed for two crystallographic orientations on single-crystal Fe, but not on the third. A lthough the (say) right electrode (FeC o) lies on the negative-slope side, the left electrode (Fe) lies on the positive-slope side of the Slater-Pauling curve where high 3d density exists for both signs of spin so that there may be little di erence between $_+$ and $_-$ Junctions with both electrodes taken from the negative-slope side may yield a more pronounced thickness dependence of TMR on barrier thickness according to the

present theory.

A cknow ledgm ents. The author is grateful to G.M athon for a related preprint, and for helpful discussions with W.Butler, E.T sym bal, K.Belashchenko, M.Stiles, Y.Bazaliy, J.Sun, S.S.P.Parkin, P.Nguyen, G.Fuchs, D.W orledge, and P. V isocher.

References

- [1] J.C.Slonczewski, Phys. Rev. B, 39, 6995 (1989).
- [2] S.I.K iselev et al, Nature, 425, 380 (2003).
- [3] W.H.Rippard, M.R.Pufall, S.Kaka, S.E.Russek, and T.J.Silva, Phys. Rev. Lett. 92, 027201 (2004).
- [4] J.S.Moodera, L.R.Kinder, T.M.Wong, and R.Meservey, Phys. Rev. Lett. 74, 3273 (1995).
- [5] S.S.P.Parkin, in Spin Dependent Transport in Magnetic Nanostructures (Taylor & Francis, 2002), p. 237.
- [6] Y. Huai, F. Albert, P. Nguyen, M. Pakala, and T. Valet, Appl. Phys. Lett. 84, 3118 (2004).
- [7] G.D.Fuchs, N.C.Em ley, I.N.Krivorotov, P.M.Braganca, E.M.Ryan, S.I. Kiselev, J.C.Sankey, D.C.Ralph, R.A.Buhm an, and J.A.Katine, Appl. Phys.Lett. 85, 1205 (2004).
- [8] J. Slonczewski, Frontiers in Magnetism 99. Stockholm, 12–15 August 1999, arX iv: cond-m at/0205055.
- [9] J.S.M oodera and G.M athon, J.M ag.M ag.M ats. 200, 248 (1999).
- [10] T.M iyazaki, Chapter 3 in Spin Dependent Transport in Magnetic Nanostructures, edited by S.Maekawa and T.Shinjo (Taylor & Francis, 2002).
- [11] S.M aekawa, S.Takahashi, and H. Im am ura, Chapter 4 in Spin D ependent Transport in M agnetic N anostructures (Taylor & Francis, 2002).
- [12] E.Y.Tsymbal, O.N.M ryasov, and P.R.LeClair, J.Phys.: Condens. M atter 15, R109 (2003).
- [13] R.Meservey and P.M. Tedrow, Physics Reports 238, 173 (1994).
- [14] M. Julliere, Phys. Lett. 54A, 225 (1975).

- [15] E.Y.Tsym baland D.G.Pettifor, Phys.Rev.B 58, 432 (1998).
- [16] J.M athon and A.Um erski, Phys. Rev. B 60, 1117 (1999).
- [17] K.D.Belashchenko, E.Y.Tsymbal, M. van Schilfgaarde, D.A.Stewart, I.I. Oleynik, and S.S.Jaswal, Phys. Rev. B 69, 174408 (2004).
- [18] J.Bardeen, Phys. Rev. Letts. 6, 57 (1961).
- [19] C.B.Duke, Tunneling in Solids, (A cadem ic Press, New York, 1969), Sec. 18a, Eqs. (8.11-8.14)
- [20] J.Slonczewski, J.M agn.M agn.M ater. 247, 324 (2002).
- [21] L.Berger, Phys. Rev. B 54, 9353 (1996).
- [22] Y.B.Bazaliy, B.A. Jones, and S.C. Zhang, Phys. Rev. B 57, R 3213 (1998).
- [23] J. Slonczewski, J.M agn.M agn.M ats. 195, L261 (1999).
- [24] M.D. Stiles and A. Zangwill, Phys. Rev. B 66, 014407 (2002).
- [25] F.J.Albert, N.C.Emley, E.B.M yers, D.C.Ralph, and R.A.Buhrm an, Phys. Rev.Lett. 89, 226802 (2002).
- [26] D.M.Edwards, F.Federici, J.Mathon, and A.Umerski, preprint.
- [27] J.Bass and W.P.Pratt, Jr., J.M agn.M agn.M ats. 200, 274 (1999).
- [28] J. Kubler, Theory of Itinerant Electron Magnetism (Oxford Science Publications, 2000).
- [29] T.Valet and A.Fert, Phys. Rev. B 48, 7099 (1993).
- [30] Eq. (18.34) in Ref. [19].
- [31] N. Tezuka and T. Miyazaki, J. Magn. and Magn. Mats. 177-181, 1283 (1998).
- [32] Fei-feiLi, Zheng-zhong Li, Ming-wen Xiao, Jun Du, Wang Xu, An Hu, and John Q. Xiao, J. Appl. Phys. 95 7243 (2004).
- [33] See, for example, A.C. Smith, J.F. Janak, and R.S. Adler, Electronic Conduction in Solids (M cG raw -H ill 1967) p. 125.

[34] Ref. [28], p. 234.